

2SA1924

High-Voltage Switching Applications

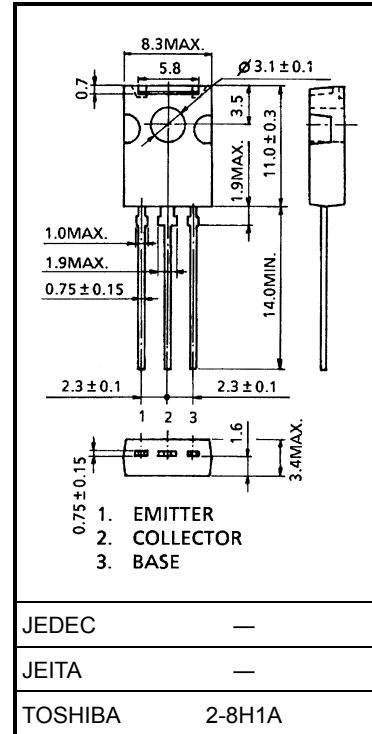
- High breakdown voltage: $V_{CEO} = -400\text{ V}$
- Low saturation voltage: $V_{CE(sat)} = -1\text{ V (max)}$
($I_C = -100\text{ mA}$, $I_B = -10\text{ mA}$)
- Collector metal (fin) is fully covered with mold resin.

Absolute Maximum Ratings ($T_c = 25^\circ\text{C}$)

Characteristics		Symbol	Rating	Unit
Collector-base voltage		V_{CBO}	-400	V
Collector-emitter voltage		V_{CEO}	-400	V
Emitter-base voltage		V_{EBO}	-7	V
Collector current	DC	I_C	-0.5	A
	Pulse	I_{CP}	-1	
Base current		I_B	-0.25	A
Collector power dissipation	$T_a = 25^\circ\text{C}$	P_C	1.5	W
	$T_c = 25^\circ\text{C}$		10	
Junction temperature		T_j	150	$^\circ\text{C}$
Storage temperature range		T_{stg}	-55 to 150	$^\circ\text{C}$

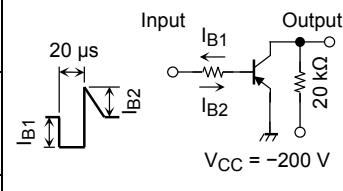
Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Unit: mm

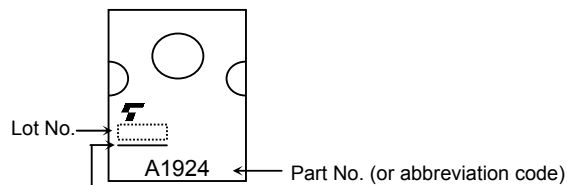


Weight: 0.82 g (typ.)

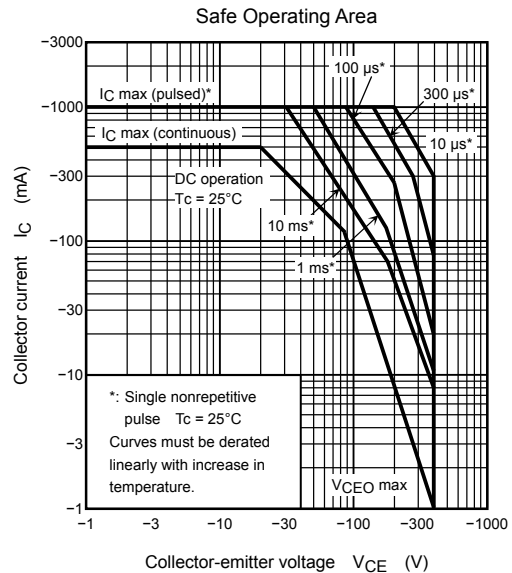
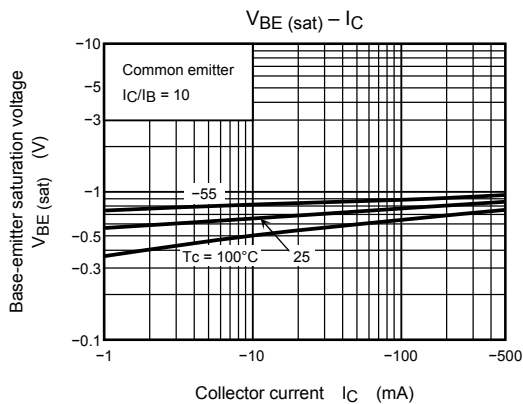
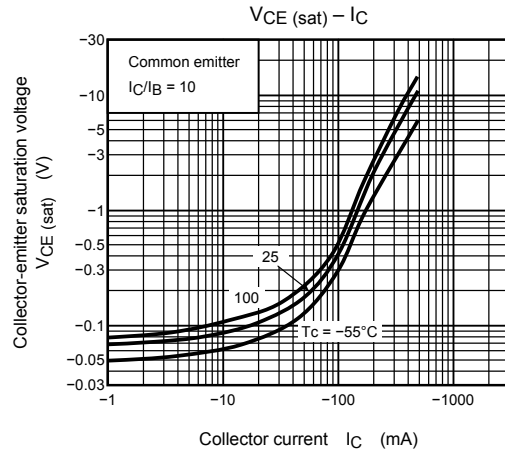
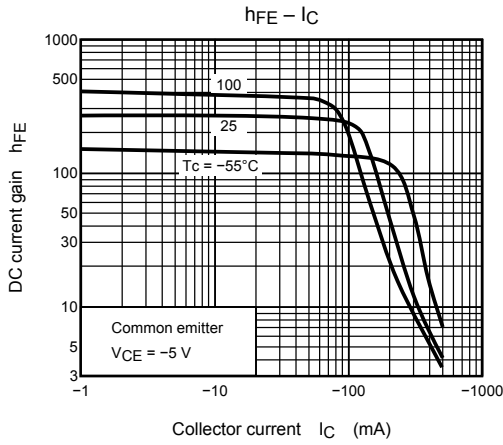
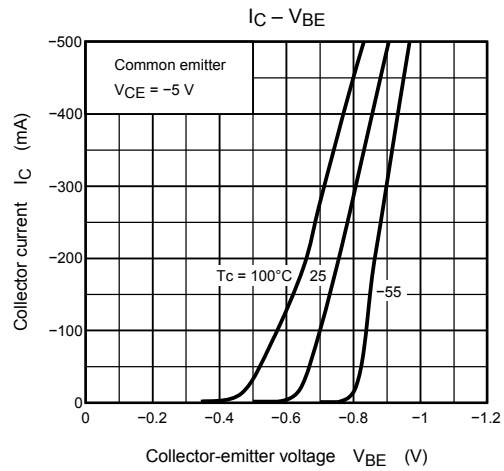
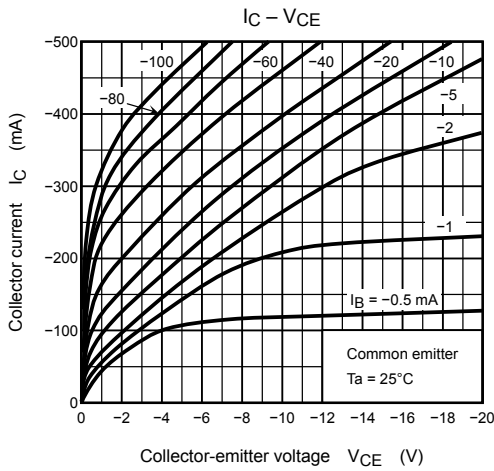
Electrical Characteristics (Tc = 25°C)

Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Collector cut-off current		I_{CBO}	$V_{CB} = -400\text{ V}, I_E = 0$	—	—	-10	μA
Emitter cut-off current		I_{EBO}	$V_{EB} = -7\text{ V}, I_C = 0$	—	—	-1	μA
Collector-emitter breakdown voltage		V_{CEO}	$I_C = -10\text{ mA}, I_B = 0$	-400	—	—	V
DC current gain		$h_{FE} (1)$	$V_{CE} = -5\text{ V}, I_C = -20\text{ mA}$	140	—	450	
		$h_{FE} (2)$	$V_{CE} = -5\text{ V}, I_C = -100\text{ mA}$	140	—	400	
Collector-emitter saturation voltage		$V_{CE} (\text{sat})$	$I_C = -100\text{ mA}, I_B = -10\text{ mA}$	—	-0.4	-1.0	V
Base-emitter saturation voltage		$V_{BE} (\text{sat})$	$I_C = -100\text{ mA}, I_B = -10\text{ mA}$	—	-0.76	-0.9	V
Transition frequency		f_T	$V_{CE} = -5\text{ V}, I_C = -50\text{ mA}$	—	35	—	MHz
Collector output capacitance		C_{ob}	$V_{CB} = -10\text{ V}, I_E = 0, f = 1\text{ MHz}$	—	18	—	pF
Switching time	Turn-on time	t_{on}	 <p style="text-align: center;">$V_{CC} = -200\text{ V}$</p>	—	0.2	—	μs
	Storage time	t_{stg}		—	2.3	—	
	Fall time	t_f		$I_{B1} = -10\text{ mA}, I_{B2} = 20\text{ mA},$ duty cycle $\leq 1\%$	—	0.2	

Marking



A line indicates lead (Pb)-free finish.



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20070701-EN GENERAL

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